



P-Channel 80 V (D-S) MOSFET



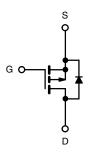
Marking code: E7

PRODUCT SUMMARY						
V _{DS} (V)	-80					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -10 \text{ V}$	0.270					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -6 \text{ V}$	0.303					
Q _g typ. (nC)	7					
I _D (A) ^a	-2.2					
Configuration	Single					

FEATURES

- TrenchFET® power MOSFET
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912





P-Channel MOSFET

ORDERING INFORMATION				
Package	SOT-23			
Lead (Pb)-free	Si2337DS-T1-E3			
Lead (Pb)-free and halogen-free	Si2337DS-T1-GE3			

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage		V _{DS}	-80	V	
Gate-source voltage	V _{GS}	± 20			
	T _C = 25 °C		-2.2		
Continuous dusin surrent (T. 150 °C)	T _C = 70 °C		-1.75		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	-1.2 ^{b, c}		
	T _A = 70 °C		-0.96 ^{b, c}	^	
Pulsed drain current	I _{DM}	-7	A		
Continuous source-drain diode current	T _C = 25 °C		-2.1		
	T _A = 25 °C	l _S	-0.63 ^{b, c}		
Avalanche current		I _{AS}	11		
Single-pulse avalanche energy	L = 0.1 mH	E _{AS}	6	mJ	
Maximum power dissipation	T _C = 25 °C		2.5		
	T _C = 70 °C		1.6	w	
	T _A = 25 °C	P _D	0.76 ^{b, c}	VV	
	T _A = 70 °C		0.48 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	**	
Soldering recommendations (peak temperature		260	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, d	t ≤ 10 s	R_{thJA}	120	166	°C/W	
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	40	50	C/W	

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 166 °C/W

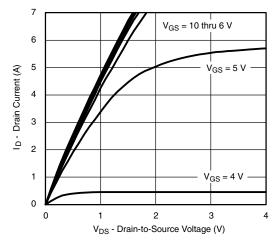
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					L		
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-80	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		-	-35.8	-	mc\//04	
V _{GS(th)} temperature coefficient	$\Delta VG_{S(th)}/T_{J}$	I _D = -250 μA	-	5.45	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-2	-	-4	٧	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
		$V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}$		-	-1		
Zero gate voltage drain current	I _{DSS}	V _{DS} = -80 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-10	μA	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	-7	-	-	Α	
	D(OH)	V _{GS} = -10 V, I _D = -1.2 A	_	0.216	0.270	<u> </u>	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = -6 V, I _D = -1.1 A	_	0.242	0.303	Ω	
Forward transconductance a	9 _{fs}	$V_{DS} = -15 \text{ V, } I_D = -1.2 \text{ A}$	_	4.3	-	S	
Dynamic ^b	9ts	V _{DS} = 10 V, I _D = 1.2 / 1		7.0			
Input capacitance	C _{iss}		_	500	<u> </u>		
Output capacitance	C _{oss}	$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	40	_	pF	
Reverse transfer capacitance	C _{rss}	VDS = 10 V, VGS = 0 V, I = 1 WH IZ	_	25	_		
Total gate charge	Orss	$V_{DS} = -40 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -1.2 \text{ A}$	_	11	17	nC	
	Q_g	VDS = 40 V, VGS = 10 V, ID = 1.270	_	7	11		
Gate-source charge	Q _{qs}	$V_{DS} = -40 \text{ V}, V_{GS} = -6 \text{ V}, I_D = -1.2 \text{ A}$	_	2.1	-		
Gate-drain charge	Q _{gd}	V _{DS} = 10 V, V _{GS} = 0 V, I _D = 1.27V	_	3.2	_		
Gate resistance	R _a	f = 1 MHz	_	4.8	_	Ω	
Turn-on delay time	t _{d(on)}		_	10	15	32	
Rise time	t _r	$V_{DD} = -40 \text{ V}, R_{L} = 42 \Omega$	_	15	23		
Turn-off delay time	t _{d(off)}	$I_D \cong -0.96 \text{ A, } V_{GEN} = -10 \text{ V, } R_q = 1 \Omega$	-	20	30		
Fall time	t _f	,	-	15	23		
Turn-on delay time	t _{d(on)}		-	15	23	ns	
Rise time	t _r	$V_{DD} = -40 \text{ V}, R_1 = 42 \Omega$	-	18	27	- - -	
Turn-off delay time	t _{d(off)}	$I_D \cong -0.96 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$	-	20	30		
Fall time	t _f		-	12	18		
Drain-Source Body Diode Characteristi	cs				l	l	
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	-2.1		
Pulse diode forward current ^a	I _{SM}	•	-	-	-7	Α	
Body diode voltage	V _{SD}	I _S = 0.63 A	_	-0.8	-1.2	V	
Body diode reverse recovery time	t _{rr}	-	-	30	45	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 0.63 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	45	70	nC	
Reverse recovery fall time	ta	$T_{\rm J} = 25 ^{\circ}{\rm C}$	-	25	-		
Reverse recovery rise time	t _b		-	5	-	ns	

Notes

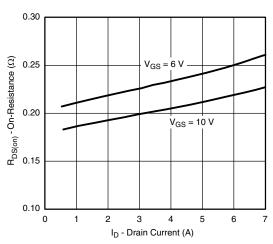
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

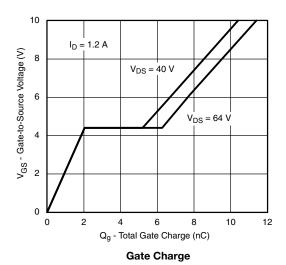


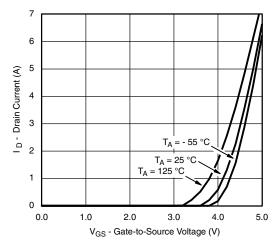


Output Characteristics

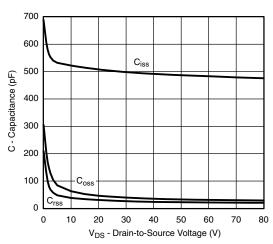


On-Resistance vs. Drain Current and Gate Voltage

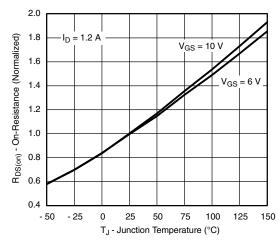




Transfer Characteristics

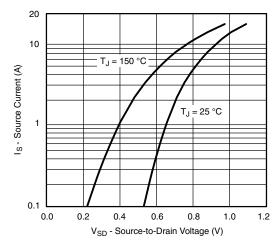


Capacitance

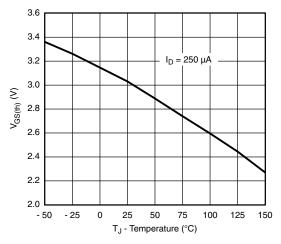


On-Resistance vs. Junction Temperature

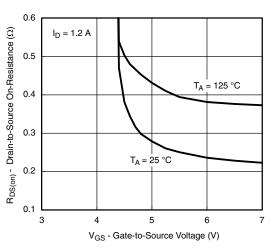




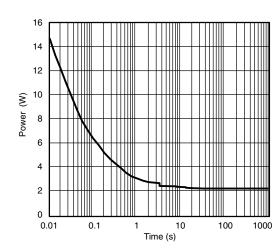
Source-Drain Diode Forward Voltage



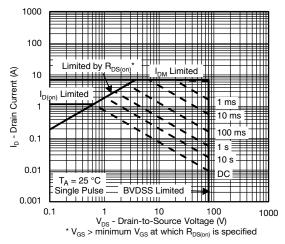
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

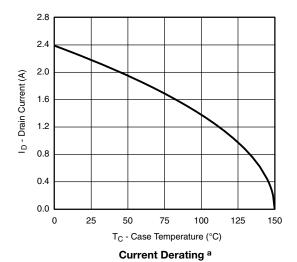


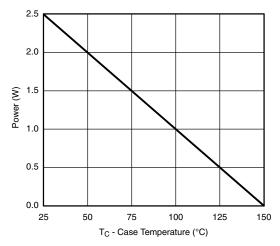
Single Pulse Power, Junction-to-Ambient



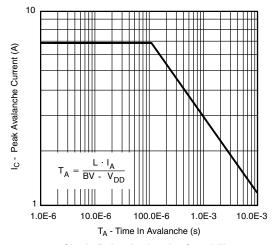
Safe Operating Area, Junction-to-Ambient







Power Derating

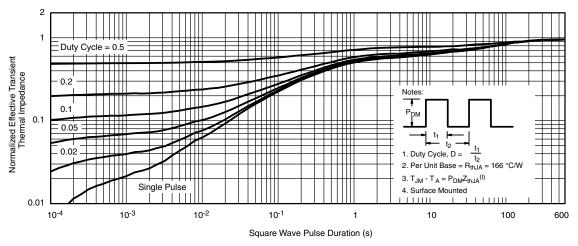


Single Pulse Avalanche Capability

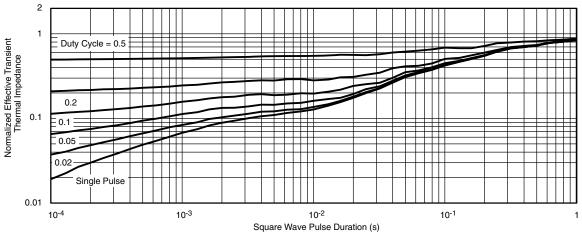
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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Vishay Siliconix

SOT-23 (TO-236): 3-LEAD







Dim	MILLI	METERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
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ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479

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RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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